

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination SENDAI, TOMONARI	
		Examiner Shawna J. Shaw	Art Unit 3737	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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X	B	US-6,433,345 B1	08-2002	Hayashi et al.	250/458.1
X	C	US-6,422,994 B1	07-2002	Kaneko et al.	600/160
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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